Gallium Nitride 50V, 450W, 4.6-5GHz RF Power Transistor

Description

The STCV50450BY4V is a 450-watt, internally matched GaN HEMT, designed for 5G cellular applications with frequencies from 4.6-5.0GHz, enabled by wide band VBW capability to support IBW≥200MHz.

It can be configured as asymmetrical Doherty for 5G application, delivering 55W average power, according to normal 9dB back off.

Typical Doherty Pulsed CW and 1C W--CDMA Characterization Performance: •

(1)Pulsed condition: 100us and 10% (2)1C WCDMA; Signal PAR = 10 dB @ 0.01% Probability on CCDF.

VDS= 50V, IDQ-main=230 mA Vgs-main=-3.0V. Vgs-peak=-6.5V

Freq	Pulse CW Signal ⁽¹⁾			Pavg	=47.5dBm WC	CDMA Signal ⁽²⁾
(GHz)	GainP1 (dB)	P3 (dBm)	P3 (W)	Gp (dB)	η ⊳ (%)	ACPR₅M (dBc)
4.6	9.56	56.79	478	9.95	39.96	-33.33
4.7	9.95	56.80	478	10.31	41.78	-36.84
4.8	10.56	56.59	456	10.39	41.84	-36.44
4.9	10.36	56.45	442	10.18	41.37	-34.74
5.0	9.90	56.35	431	9.57	39.53	-32.38

Important Note: Proper Biasing Sequence for GaN HEMT Transistors

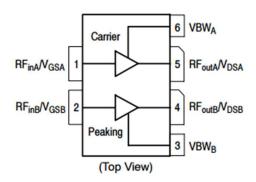
Turning the device ON

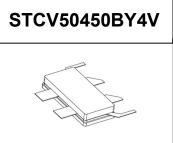
- 1. Set VGS to the pinch-off (VP) voltage, typically -5 V
- 2. Turn on VDS to nominal supply voltage
- 3. Increase VGS until IDS current is attained
- 4. Apply RF input power to desired level

Turning the device OFF

- 1. Turn RF power off
- 2. Reduce VGS down to VP, typically -5 V
- 3. Reduce VDS down to 0 V
- 4. Turn off VGS







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Table 1. Maximum Ratings

Symbol	Value	Unit
V _{DSS}	+200	Vdc
V _{GS}	-8 to +0.5	Vdc
V _{DD}	55	Vdc
lgs	55.6	mA
Tstg	-65 to +150	°C
T _c	+150	°C
TJ	+225	°C
	V _{DSS} V _{GS} V _{DD} Igs Tstg T _c	V _{DSS} +200 V _{GS} -8 to +0.5 V _{DD} 55 Igs 55.6 Tstg -65 to +150 T _c +150

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA	Rejc	1.2	°C /W
T _c = 85°C, Pout=90W, 4.9GHz Doherty application board	KAIC	1.3	C / W

Table 3. Electrical Characteristics (TA = 25°C unless otherwise noted)

DC Characteristics (main path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=21.6mA	V _{DSS}		200		V
Gate Threshold Voltage	VDS =10V, ID = 21.6mA	V _{GS(th)}	-4		-2	V
Gate Quiescent Voltage	VDS =50V, IDS=280mA, Measured in Functional Test	V _{GS(Q)}		-3.07		V

DC Characteristics (peak path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Drain-Source Breakdown Voltage	VGS=-8V; IDS=34mA	V _{DSS}		200		V
Gate Threshold Voltage	VDS =10V, ID = 34mA	V _{GS(th)}	-4		-2	V
Gate Quiescent Voltage	VDS =50V, IDS=280mA Measured in Functional Test	V _{GS(Q)}		-3.3		V

Ruggedness Characteristics

Characteristic	Conditions	Symbol	Min	Тур	Max	Unit
Load mismatch capability	4.9GHz, Pout=55W WCDMA 1 Carrier in Doherty circuit All phase, No device damages	VSWR		10:1		



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Typical performance 4600-5000MHz Doherty

Figure 2: Intermodulation Distortion Products versus Two--Tone Spacing

Vdd=50V, Pout=47.5dBm, Center Frequency=4.9GHz

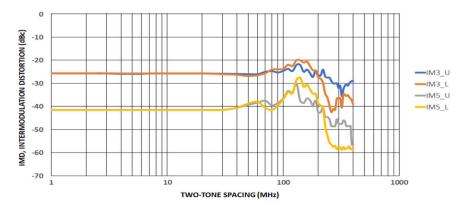
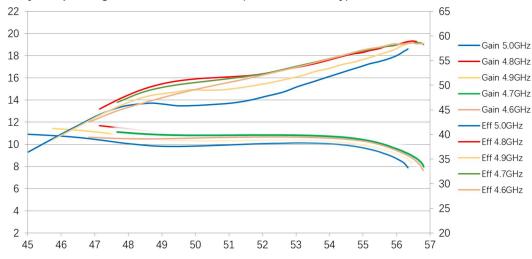


Figure 3: Efficiency and power gain as function of Pout (4.6-5GHz Doherty)





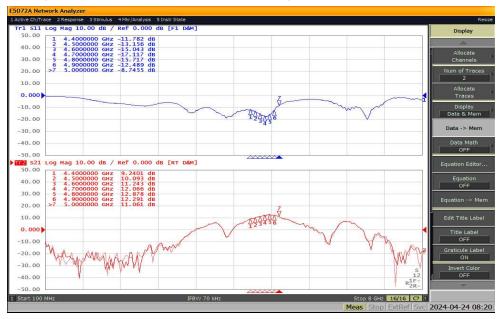
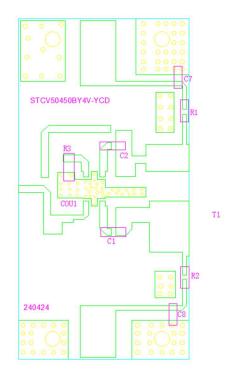


Figure 5: Picture of application board Doherty circuit for 4.6-5GHz



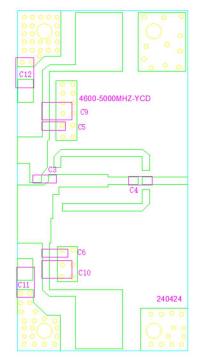
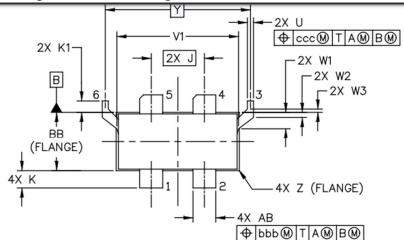


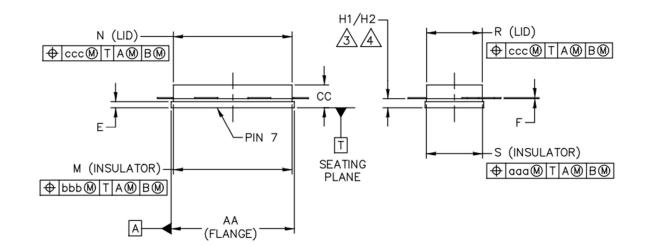
Table 4. Bill of materials of application board (PCB layout upon request, RO4350B 20mils)

Part	Quantity	Description	Part Number	Supplier
C1,C2,C4,C5,C6,	7	3.9pFHigh Q	251SHS3R9BSE	TEMEX
C7,C8		Capacitor		
C3	1	0.9pFHigh Q	251SHSOR9BSE	TEMEX
		Capacitor		
C9,C10,C11,C12	4	10uF MLCC	GRM32EC72A106M	Murata
			E05	
R1,R2	2	10 Ω Power	ESR03EZPF100	ROHM
		Resistor		
R3	1	51 Ω Power	S1206N	RN2
		Resistor		
COUT1	1	3 dB Hybrid	X3C45F1-03S	Anaren
T1	1	450W GaN	STCV50450BY4V	Innogration
		Dual Transistor		

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Earless Flanged Ceramic Package; 6 leads- BY4V





	IN	INCH		MILLIMETER		IN	СН	MILLIM	ETER
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
AA	.805	.815	20.45	20.70	R	.365	.375	9.27	9.53
BB	.380	.390	9.65	9.91	S	.365	.375	9.27	9.53
CC	.125	.170	3.18	4.32	U	.035	.045	0.89	1.14
E	.035	.045	0.89	1.14	V1	.795	.805	20.19	20.45
F	.004	.007	0.10	0.18	W1	.0975	.1175	2.48	2.98
H1	.057	.067	1.45	1.70	W2	.0225	.0425	0.57	1.08
H2	.054	.070	1.37	1.78	W3	.0125	.0325	0.32	0.83
J	.350 BSC		8.89	8.89 BSC		.956	BSC	24.28	BSC
к	.0995	.1295	2.53	3.29	Z	R.000	R.040	R0.00	R1.02
K1	.070	.090	1.78	2.29	AB	.145	.155	3.68	3.94
М	.774	.786	19.66	19.96	aaa	.0	005	0.1	3
Ν	.772	.788	19.61	20.02	bbb	.0)10	0.2	5
					ccc	.0)15	0.3	8

Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2023/5/31	V2.0	Preliminary Datasheet Creation, according to latest application result
2024/4/25	V2.1	Modify application data according to improvement

Application data based on LWH-23-12/24-14

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